

<b>Notice of References Cited</b>	Application/Control No. 10/796,251	Applicant(s)/Patent Under Reexamination ITOH ET AL.	
	Examiner Yoon-Young Kim	Art Unit 1723	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-4,871,456	10-1989	Naruo et al.	210/321.84
*	C	US-2003/0159981 A1	08-2003	Diemer et al.	210/346
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	K	US-			
	L	US-			
	M	US-			

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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